



Cambridge International AS & A Level

PHYSICS

9702/52

Paper 5 Planning, Analysis and Evaluation

May/June 2022

MARK SCHEME

Maximum Mark: 30

Published

This mark scheme is published as an aid to teachers and candidates, to indicate the requirements of the examination. It shows the basis on which Examiners were instructed to award marks. It does not indicate the details of the discussions that took place at an Examiners' meeting before marking began, which would have considered the acceptability of alternative answers.

Mark schemes should be read in conjunction with the question paper and the Principal Examiner Report for Teachers.

Cambridge International will not enter into discussions about these mark schemes.

Cambridge International is publishing the mark schemes for the May/June 2022 series for most Cambridge IGCSE, Cambridge International A and AS Level and Cambridge Pre-U components, and some Cambridge O Level components.

This document consists of **11** printed pages.

PUBLISHED**Generic Marking Principles**

These general marking principles must be applied by all examiners when marking candidate answers. They should be applied alongside the specific content of the mark scheme or generic level descriptors for a question. Each question paper and mark scheme will also comply with these marking principles.

GENERIC MARKING PRINCIPLE 1:

Marks must be awarded in line with:

- the specific content of the mark scheme or the generic level descriptors for the question
- the specific skills defined in the mark scheme or in the generic level descriptors for the question
- the standard of response required by a candidate as exemplified by the standardisation scripts.

GENERIC MARKING PRINCIPLE 2:

Marks awarded are always **whole marks** (not half marks, or other fractions).

GENERIC MARKING PRINCIPLE 3:

Marks must be awarded **positively**:

- marks are awarded for correct/valid answers, as defined in the mark scheme. However, credit is given for valid answers which go beyond the scope of the syllabus and mark scheme, referring to your Team Leader as appropriate
- marks are awarded when candidates clearly demonstrate what they know and can do
- marks are not deducted for errors
- marks are not deducted for omissions
- answers should only be judged on the quality of spelling, punctuation and grammar when these features are specifically assessed by the question as indicated by the mark scheme. The meaning, however, should be unambiguous.

GENERIC MARKING PRINCIPLE 4:

Rules must be applied consistently, e.g. in situations where candidates have not followed instructions or in the application of generic level descriptors.

GENERIC MARKING PRINCIPLE 5:

Marks should be awarded using the full range of marks defined in the mark scheme for the question (however; the use of the full mark range may be limited according to the quality of the candidate responses seen).

GENERIC MARKING PRINCIPLE 6:

Marks awarded are based solely on the requirements as defined in the mark scheme. Marks should not be awarded with grade thresholds or grade descriptors in mind.

Science-Specific Marking Principles

- 1 Examiners should consider the context and scientific use of any keywords when awarding marks. Although keywords may be present, marks should not be awarded if the keywords are used incorrectly.
- 2 The examiner should not choose between contradictory statements given in the same question part, and credit should not be awarded for any correct statement that is contradicted within the same question part. Wrong science that is irrelevant to the question should be ignored.
- 3 Although spellings do not have to be correct, spellings of syllabus terms must allow for clear and unambiguous separation from other syllabus terms with which they may be confused (e.g. ethane / ethene, glucagon / glycogen, refraction / reflection).
- 4 The error carried forward (ecf) principle should be applied, where appropriate. If an incorrect answer is subsequently used in a scientifically correct way, the candidate should be awarded these subsequent marking points. Further guidance will be included in the mark scheme where necessary and any exceptions to this general principle will be noted.
- 5 'List rule' guidance
 For questions that require *n* responses (e.g. State **two** reasons ...):
 - The response should be read as continuous prose, even when numbered answer spaces are provided.
 - Any response marked *ignore* in the mark scheme should not count towards *n*.
 - Incorrect responses should not be awarded credit but will still count towards *n*.
 - Read the entire response to check for any responses that contradict those that would otherwise be credited. Credit should **not** be awarded for any responses that are contradicted within the rest of the response. Where two responses contradict one another, this should be treated as a single incorrect response.
 - Non-contradictory responses after the first *n* responses may be ignored even if they include incorrect science.

6 Calculation specific guidance

Correct answers to calculations should be given full credit even if there is no working or incorrect working, **unless** the question states 'show your working'.

For questions in which the number of significant figures required is not stated, credit should be awarded for correct answers when rounded by the examiner to the number of significant figures given in the mark scheme. This may not apply to measured values.

For answers given in standard form (e.g. $a \times 10^n$) in which the convention of restricting the value of the coefficient (a) to a value between 1 and 10 is not followed, credit may still be awarded if the answer can be converted to the answer given in the mark scheme.

Unless a separate mark is given for a unit, a missing or incorrect unit will normally mean that the final calculation mark is not awarded. Exceptions to this general principle will be noted in the mark scheme.

7 Guidance for chemical equations

Multiples / fractions of coefficients used in chemical equations are acceptable unless stated otherwise in the mark scheme.

State symbols given in an equation should be ignored unless asked for in the question or stated otherwise in the mark scheme.

Annotations

✓	Correct point Method of analysis marks in Question 1
✓ ₁₋₁₀	Additional detail marks in Question 1
X	Incorrect point
^	Omission
BOD	Benefit of the doubt
NBOD	No benefit of the doubt given
ECF	Error carried forward
P	Defining the problem marks in Question 1 Power of ten error in Question 2
M0	Methods of data collection marks in Question 1
SF	Incorrect number of significant figures

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Question	Answer	Marks
1	Defining the problem	
	<i>L</i> is the independent variable and <i>I</i> is the dependent variable or vary <i>L</i> and measure <i>I</i>	1
	keep <i>E</i> constant	1
	Methods of data collection	
	labelled diagram of workable experiment including: <ul style="list-style-type: none"> • circuit diagram with power supply connected to ends C • ammeter in series with power supply and conductors • correct symbol for ammeter and power supply 	1
	circuit diagram with voltmeter correctly positioned to measure <i>E</i> across the power supply	1
	use a rule(r) to measure <i>L</i> and <i>x</i>	1
	use a micrometer/calipers to measure <i>y</i>	1

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Question	Answer	Marks
1	Method of analysis	
	plot a graph of $\frac{1}{I}$ against L or equivalent (e.g. L against $\frac{1}{I}$) (Do not accept log graphs.)	1
	$P = \frac{\text{gradient} \times AE}{2}$ (for L against $\frac{1}{I}$: $P = \frac{AE}{2 \times \text{gradient}}$)	1
	$Q = \frac{y\text{-intercept} \times Ey^2}{x}$ (for L against $\frac{1}{I}$: $Q = -\frac{y\text{-intercept} \times 2Py^2}{Ax}$ or $Q = -\frac{y\text{-intercept} \times Ey^2}{\text{gradient} \times x}$)	1

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Question	Answer	Marks
1	Additional detail including safety considerations	6
	D1 do not touch/use (heat resistant) gloves to avoid <u>hot</u> conductors/metal bar or use a protective resistor/small e.m.f. to reduce the <u>current</u> or switch off when not in use/when moving bar	
	D2 keep A and y <u>constant</u>	
	D3 keep x <u>constant</u>	
	D4 use of micrometer/calipers to measure <u>diameter</u> of conductor and $A = \pi d^2 / 4$.	
	D5 repeat measurements of diameter <u>along conductors/different (perpendicular) directions/different points</u> and average or repeat measurements of y in <u>different (perpendicular) directions/different points/along bar</u> and average	
	D6 method to ensure that L is the same for each conductor, e.g. check both lengths	
	D7 method to determine L e.g. measure to edge and add $y/2$ or method to determine x e.g. measure between the conductors and add diameter	
	D8 method to keep x constant <u>with reason</u> , e.g. adhesive/plasticine/blocks (one either side of each conductor) <u>to prevent cylindrical conductors from moving</u>	
	D9 method of ensuring good electrical contact, e.g. clean metal bar/cylindrical conductors or use of solder or crocodile clips to connect circuit to the conductors	
	D10 relationship valid <u>if</u> a straight line is produced (not passing through the origin)	

Question	Answer	Marks														
2(a)	gradient = a y-intercept = $\lg SK$	1														
2(b)	<table border="1" data-bbox="826 325 1449 796"> <thead> <tr> <th data-bbox="826 325 1032 389">$\lg (T / \text{days})$</th> <th data-bbox="1032 325 1449 389">$\lg (L / 10^{30} W)$</th> </tr> </thead> <tbody> <tr> <td data-bbox="826 389 1032 453">1.34 or 1.342</td> <td data-bbox="1032 389 1449 453">0.46 or 0.462 ± 0.03</td> </tr> <tr> <td data-bbox="826 453 1032 517">1.51 or 1.505</td> <td data-bbox="1032 453 1449 517">0.69 or 0.690 ± 0.02</td> </tr> <tr> <td data-bbox="826 517 1032 580">1.62 or 1.623</td> <td data-bbox="1032 517 1449 580">0.84 or 0.839 ± 0.01</td> </tr> <tr> <td data-bbox="826 580 1032 644">1.73 or 1.732</td> <td data-bbox="1032 580 1449 644">0.99 or 0.991 ± 0.01</td> </tr> <tr> <td data-bbox="826 644 1032 708">1.89 or 1.892</td> <td data-bbox="1032 644 1449 708">1.20 or 1.204 ± 0.05 or 0.06</td> </tr> <tr> <td data-bbox="826 708 1032 796">1.99 or 1.987</td> <td data-bbox="1032 708 1449 796">1.32 or 1.322 ± 0.04</td> </tr> </tbody> </table> <p data-bbox="327 831 1173 863">Values of $\lg (T / \text{days})$ and $\lg (L / 10^{30} W)$ correct as shown above.</p>	$\lg (T / \text{days})$	$\lg (L / 10^{30} W)$	1.34 or 1.342	0.46 or 0.462 ± 0.03	1.51 or 1.505	0.69 or 0.690 ± 0.02	1.62 or 1.623	0.84 or 0.839 ± 0.01	1.73 or 1.732	0.99 or 0.991 ± 0.01	1.89 or 1.892	1.20 or 1.204 ± 0.05 or 0.06	1.99 or 1.987	1.32 or 1.322 ± 0.04	1
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	Absolute uncertainties in $\lg (L / 10^{30} W)$ correct as shown above.	1														
2(c)(i)	Six points from (b) plotted correctly. Must be within half a small square. Diameter of points must be less than half a small square.	1														
	Error bars in $\lg (L / 10^{30} W)$ plotted correctly. All error bars must be plotted. Total length of bar must be accurate to less than half a small square and symmetrical.	1														
2(c)(ii)	Straight line of best fit drawn. Points must be balanced. Do not accept line from top point to bottom point. Line must pass between (1.43, 0.60) and (1.45, 0.60) and between (1.84, 1.15) and (1.86, 1.15).	1														
	Worst acceptable line drawn (steepest or shallowest possible line that passes through all the error bars). All error bars must be plotted.	1														

Question	Answer	Marks
2(c)(iii)	Gradient determined with clear substitution of data points into $\Delta y / \Delta x$. Distance between data points must be greater than half the length of the drawn line.	1
	Gradient of worst acceptable line determined. uncertainty = (gradient of line of best fit – gradient of worst acceptable line) or uncertainty = $\frac{1}{2}$ (steepest worst line gradient – shallowest worst line gradient)	1
2(c)(iv)	y-intercept determined by substitution into $y = mx + c$.	1
	y-intercept of worst acceptable line determined by substitution into $y = mx + c$. uncertainty = y-intercept of line of best fit – y-intercept of worst acceptable line or uncertainty = $\frac{1}{2}$ (steepest worst line y-intercept – shallowest worst line y-intercept) Do not allow methods using a false origin.	1

Question	Answer	Marks
2(d)	$a = \text{gradient} = \mathbf{(c)(iii)}$ and a and K both given to two or three significant figures.	1
	Value of K determined using y -intercept. Correct method must be seen. $K = \frac{10^{y\text{-intercept}} \times 10^{30}}{S} = \frac{10^{(c)(iv)} \times 10^{30}}{3.85 \times 10^{26}}$ or $K = 10^{y\text{-intercept} - \lg S} \times 10^{30}$ or $K = 10^{(c)(iv) - \lg 3.85 \times 10^{26}} \times 10^{30}$	1
	absolute uncertainty in $a = \text{absolute uncertainty in gradient}$ and $\Delta K = \frac{(10^{y\text{-intercept}} - 10^{\text{WAL } y\text{-intercept}}) \times 10^{30}}{S}$ Correct substitution of numbers must be seen.	1
2(e)	L determined from (d) or (c)(iii) and (c)(iv) with correct substitution <u>and</u> correct power of ten(s). Do not accept incorrect POT for a or K . $L = 3.85 \times 10^{26} \times \mathbf{(d)} \times 5.0^{(c)(iii)}$ or $\lg L = \mathbf{(c)(iii)} \times \lg 5.0 + y\text{-intercept}$	1